Reexamination 10/511,238 CHANG ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1

YONG SIM 2629

Applicant(s)/Patent Under

U.S. PATENT DOCUMENTS

Application/Control No.

	U.S. FATENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification		
*	Α	US-2003/0001815 A1	01-2003	Cui, Ying	345/102		
*	В	US-2003/0065472 A1	04-2003	Eckel et al.	702/130		
*	O	US-6,593,943 B1	07-2003	MacPhail, Margaret Gardner	715/734		
	D	US-					
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	F	US-					
	G	US-		-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS					
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